


Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	09/594,302		PAYNE ET AL.	
	Examiner		Art Unit	
	David Q. Nguyen		2681	

ISSUE CLASSIFICATION									
ORIGINAL		CROSS REFERENCE(S)							
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
455	566	455	226.4	566	575.1	412.2	405	11.1	403
INTERNATIONAL CLASSIFICATION		455	67.7						
H	0 4 B	340	7.56	3.55	7.53	7.48	7.2		
		379	88.11	88.15	88.14				

<i>Nguyen</i> (Assistant Examiner) (Date)	<i>Joseph Feild</i> SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date)	Total Claims Allowed: <i>44</i>
<i>Stadler</i> (Legal Instruments Examiner) (Date)	<i>7-19-05</i> (Date)	O.G. Print Claim(s) 1
		O.G. Print Fig. FIG. 2a

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
	1		31		3		61		26		121		151		181
	2		32		4		62		27		122		152		182
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	6		36		6		66		31		126		156		186
	7		37		7		67		32		127		157		187
	8		38		8		68		33		128		158		188
	9		39		9		69		34		129		159		189
	10		40		10		70		35		130		160		190
	11		41		11		71				131		161		191
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	16		46		16		76		39		136		166		196
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	25		55				85	20			145		175		205
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	29	1	59				89	24			149		179		209
	30	2	60				90	25			150		180		210

U.S. Patent and Trademark Office

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